

United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE
United States Patent and Trademark Office
Address: COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, Virginia 22313-1450
www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/734,359	12/12/2003	Gerald W. Renken	1110-0470.01	3528	
7590 07/28/2005			EXAM	EXAMINER	
Joel H. Bock			DEB, ANJAN K		
Cook, Alex, Me	cFarron, Manzo,				
Cummings & Mehler, Ltd.			ART UNIT	PAPER NUMBER	
200 West Adams Street - Suite 2850			2858		
Chicago, IL 6	50606		DATE MAILED: 07/28/2005	5	

Please find below and/or attached an Office communication concerning this application or proceeding.

Supplementation	
	_

Notice of Allowability

Application No.	Applicant(s)	
10/734,359	RENKEN, GERALD W.	
Examiner	Art Unit	
Anian K Deb	2858	

		7	
	Anjan K. Deb	2858	
The MAILING DATE of this communication apperature All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIOF the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this app or other appropriate communication IGHTS. This application is subject to	olication. If not includ will be mailed in due	ed course. THIS
1. This communication is responsive to <u>12/12/2003</u> .			
2. The allowed claim(s) is/are <u>1-3</u> .			
3. \boxtimes The drawings filed on <u>12 December 2003</u> are accepted by	the Examiner.		
4. ☐ Acknowledgment is made of a claim for foreign priority unal ☐ All b) ☐ Some* c) ☐ None of the: 1. ☐ Certified copies of the priority documents have 2. ☐ Certified copies of the priority documents have 3. ☐ Copies of the certified copies of the priority do International Bureau (PCT Rule 17.2(a)). * Certified copies not received: ☐ Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	e been received. e been received in Application No cuments have been received in this of this communication to file a reply	national stage applica	
5. A SUBSTITUTE OATH OR DECLARATION must be subminformal PATENT APPLICATION (PTO-152) which give	nitted. Note the attached EXAMINER es reason(s) why the oath or declara	'S AMENDMENT or Nation is deficient.	IOTICE OF
6. CORRECTED DRAWINGS (as "replacement sheets") must (a) including changes required by the Notice of Draftspers 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner' Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in the stacked Examiner's comment regarding REQUIREMENT.	son's Patent Drawing Review (PTO- s Amendment / Comment or in the C .84(c)) should be written on the drawing to 37 CFR 1.121(c) sit of BIOLOGICAL MATERIAL r	Office action of one of the original	
Attachment(s) 1. ☐ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	5. ☐ Notice of Informal P 6. ☑ Interview Summary Paper No./Mail Da 7. ☑ Examiner's Amendr 8. ☑ Examiner's Stateme 9. ☐ Other	(PTO-413), te <u>7/25/2005</u> . ment/Comment	·

Application/Control Number: 10/734,359 Page 2

Art Unit: 2858

DETAILED ACTION

1. This office action is in response to application filed 12/12/2003 and interview summary filed 7/25/2005.

Examiner's Amendment

2. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

The application has been amended as follows:

In the specification, page 1, first sentence line 2, insert after "and" and before "U.S."

-- is continuation-in-part of --

In the specification, page 1, add at the end of first sentence -- now US Patent No.

6,847,213 B2 issued on January 25, 2005--.

Authorization for this examiner's amendment was given in a telephone interview with Mr. Joel H. Bock on 7/25/2005.

Allowable Subject Matter

3. Claims 1-3 are allowed.

Reasons for Allowance

4. The following is an examiner's statement of reasons for allowance:

The primary reason for allowance of the claims is the inclusion of measuring the input impedance looking into the patch (conductor) at a reference plane at the end of patch cord for calculating patch length according to the relation $L_{cord} = (NVP*c)/(\Delta f*2)$, where Δf is the frequency differences between maxima and minima of input impedance versus frequency, and NVP is the nominal velocity of wave propagation in the patch-cord, and c is free space velocity of light.

Pertinent Art

5. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Furse (US 20030222654 A1) discloses cable length determination system utilizing a standing wave reflectometer by measuring the frequency difference between the peaks, and the length (L) is determined according to the formula of $L = v/2*\Delta f$, where v is the velocity of propagation of the conductor in air, and Δf is the frequency between the peaks. Furse does not teach measuring the input impedance looking into the patch (conductor) at a reference plane.

Renken et al. (US 6,847,213 B2) discloses hand-held tester for testing and calibrating patch-cords and mated connector pair in a LAN cabling system comprising means for sending

Art Unit: 2858

and receiving a waveform of selected frequency through the patch cord, obtaining scattering parameters of patch cord and other connected components, obtaining frequency response and NVP (nominal velocity of propagation) values, and means for measuring phase. Renken et al. (US 6,847,213 B2) did not claim calculating patch-cord length L_{cord} by measuring the following parameters: phase, input impedance, frequency differences Δf between maxima and minima of input impedance versus frequency for calculating patch length according to the relation L_{cord} = $(NVP*c)/(\Delta f*2)$.

Koeman et al. (US 5,821,760) discloses hand held apparatus for testing LAN cable including patch-cord. Koeman et al. does not disclose method of calculating patch length.

Bottman (US 5,570,029) discloses LAN cable testing method including patch-cord and determining cable fault distance (length) from instrument 10 (Fig. 2A, 2B) to the fault from the relation $L = 1/2 T_F * V$, where T_F is the elapsed time of signal, and V is the propagation velocity. Bottman does not teach measuring the input impedance looking into the patch (conductor) at a reference plane.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Application/Control Number: 10/734,359

Art Unit: 2858

Page 5

Contact Information

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Dr. Anjan K. Deb whose telephone number is 571-272-2228. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Lefkowitz Edwards can be reached at 571-272-2180.

Anjan K. Deb

Tel: 571-272-2228

Patent Examiner

Fax: 571-273-2228

Art Unit: 2858

E-mail: anjan.deb@uspto.gov

7/25/05